

**Search Notes**

Application/Control No.

10/535,706

Examiner

David Mis

Applicant(s)/Patent under  
Reexamination

MAEDA ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
331	1A, 8,	10/12/2006	DM
	10-11,		
	14, 179,		
	16-18,		
	25, 34,		
	Dig. 2		
327	156-159		
375	376		
455	260		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
USPGPUB	(See	10/12/2006	DM
	History)		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR